



Page 1 of 14

**DIODES, POWER RECTIFIER, HIGH EFFICIENCY, FAST  
RECOVERY**

**BASED ON TYPE BY981-350**

**ESCC Detail Specification No. 0100/020**

Issue 1	January 2014
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**Administrative/General Notes**

(Refer to specifications for ESCC 001 series)

Item No.	General Description
101	Administrative/General Notes/Specified ESCC



## TABLE OF CONTENTS

<b>1</b>	<b><u>GENERAL</u></b>	<b>1</b>
1.1	Scope	1
1.2	Applicable Documents	1
1.3	Terms / Definitions, Abbreviations, Symbols and Units	1
1.4	The ESCC Component Number and Component Type Variants	1
1.4.1	The ESCC Component Number	1
1.4.2	Component Type Variants	1
1.5	Maximum Ratings	1
1.6	Handling/Precautions	2
1.7	Physical Dimensions and Terminal Identification	2
1.7.1	Mount Flange Mount Package (TQ-J56) – 8 Lead	2
1.7.2	Surface Mount Package (SMD) – 8 Terminal	1
1.7.3	Notes to Physical Dimensions and Terminal Identification	1
1.8	Functional Diagram	1
1.9	Materials and Values	11
<b>2</b>	<b><u>TESTING</u></b>	<b>11</b>
2.1	General	11
2.1.1	Exclusions from the General Specification	11
2.1.1.1	Exclusions from Qualification and Periodic Tests – Draw F1	11
2.2	Making	11
2.3	Terminal Strength	11
2.4	Electrical Measurements at Room, High and Low Temperatures	11
2.4.1	Room Temperature/Electrical Measurements	11
2.4.2	High and Low Temperature Electrical Measurements	11
2.4.3	Notes to Electrical Measurement Tables	12
2.5	Parameter Shift Values	12
2.6	Intermittent and End Point Electrical Measurements	12
2.7	High Temperature Reverse Bias Storage Conditions	12
2.8	Power/Storage Conditions	12
2.9	Operating Life Conditions	12
APPENDIX 10		13



## 5. GENERAL

### 5.1 SCOPE

This specification details the ratings, physical and chemical characteristics and test and inspection data for the component type. Values within the range of components specified below. It supplements the requirements of associated test result in conjunction with the ESCC Seal Specification (not under duplicate documents).

### 5.2 APPLICABLE DOCUMENTS

The following documents form part of the specification and shall be read in conjunction with it:

- a) ESCC Seal Specification No. 0100
- b) MIL-STD-1316, Test Methods and Procedures for Semiconductor Devices

### 5.3 SYMBOLS, ABBREVIATIONS, DIMENSIONS AND UNITS

For the purpose of this specification, the terms, definitions, abbreviations, symbols and units specified in ESCC Seal Specification No. 0100 shall apply.

### 5.4 THE ESCC COMPONENT NUMBERING AND COMPONENT IDENTIFICATION

#### 5.4.1 The ESCC Component Number

The ESCC Component Number shall be constructed as follows:

Example: 01000401

- e - Seal Specification Reference: 010004
- e - Component Type (Seal Number 01) (as required)

#### 5.4.2 Component Test Values

The component type covers applications this specification are as follows:

Seal Number	Material Type	Size	Description	Lead/Plating Material and Finish	Weight (max g)
01	W-PHOS-200	TC-204	Single Die	PH	0.1
02	W-PHOS-200	TC-204	Quad Die, German Die	PH	0.1
03	W-PHOS-200	TC-204	Quad Die, German Cathode	PH	0.1
04	W-PHOS-200	TC-204	Individual, wire, wire support	PH	0.1
05	W-PHOS-200	0001-5	Single Die	004	0

The lead/plating material and finish shall be in accordance with the requirements of ESCC Seal Specification No. 0100.



## 5.2 Maximum Ratings

The maximum ratings shall not be exceeded at any time during use or storage.

Maximum ratings shall only be exceeded during testing to the extent specified in this specification and when stipulated in Test Methods and Procedures of the ESCC Seal Specification.

Characteristic	Symbol	Maximum Rating	Unit	Remarks
Forward Surge Current Variable, 100 cycles Variable and IR (per Device) Variable and IR (per Device)	$I_{FSM}$	200 200 100	A	Notes 1, 2
Reverse Peak Current avg	$I_{RSM}$	200	A	Note 1
Average Forward Current Continuous Variable, 100 cycles Variable and IR (per Device) Variable and IR (per Device)	$I_{FM}$	10 10 10	A	Note 1, 2, 3, 4
Reverse Peak Current Variable, 100 cycles Variable and IR (per Device) Variable and IR (per Device)	$I_{RSM}$	10 10 10	A	Note 1
Operating Temperature Range (Case Temperature)	$T_{case}$	-55 to +125	°C	Note 1
Ambient Temperature	$T_a$	-55 to +125	°C	
Storage Temperature Range	$T_{stg}$	-55 to +125	°C	Note 1
Limiting Temperature For SO-26 For SMD-2	$T_{lim}$	+200 +200	°C	Note 5 Note 6
Moisture Resistance, Exposure to Gas M1 volume (per Device) Variable M2 and M3 (per De- vice)	$M_{1,2,3}$	10 1.0	g/cm <sup>3</sup>	Note 1, 2

## NOTES

1. Intended for use of 1000 duration.
2. Pulse duration time, 0 to 100ns.
3. At  $T_{case} = +25$  °C, device frequency 100 to 2 kHz.
4. For Variable, with the additional test limit of testing parameter at  $T_{case} = +25$  °C shall be carried out at 100% duty amplitude.
5. Duration M1 exceeds maximum and distance of not less than 1.5mm from the device body and the same test shall not be reconditioned (limbous) case exposed.
6. Duration M2 exceeds maximum and the same package shall not be reconditioned (limbous) case exposed.
7. Package mounted on an infinite heat sink.
8. For Variable M2 and M3 the "per Device" ratings apply only when both anode or cathode terminals



assembled together.

### 6.6 Seals and O-Rings (0100004)

The T12.026 passage contains Neoprene O-rings (6x3) and therefore it must not be painted, machined, sandblasted or subjected to any mechanical operation which will produce them. The seals must not be subjected to any chemical product (e.g. solvent) which will produce failure.

### 6.7 Dimensions, Annotations and Dimensional Interference (01)

Dimensioned items are given following the main drawings and dimensions.

### 6.8 Material Specifications (0100004.01)

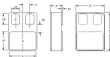


Symbol	Dimensioned Item		Notes
	Min	Max	
A	12.00	12.00	
B	12.00	12.00	
C	20.00	20.00	
D	6.0	6.7	
E	1	1.00	
ØF	6.0	6.0	
G	10.00	10.0	
H	6.00 (Min)		
I	6.00	1.00	3
J	6.00 (Min)		
K	6.00 (Min)		
L	12.00	12.0	



Symbols	Dimensions mm		Notes
	Min	Max	
200	ESCC typical		1
10	-	0.20	1
100	-	1	1
100	ESCC typical		1

## 6.2.4 Endview Glass Profiles (ESCC – Standard)



Symbols	Dimensions mm		Notes
	Min	Max	
10	200	100	
100	100	100	
10	100	100	
100	100	100	
100	200	200	1
100	200	100	1
10	100	100	
100	100	-	1
10	100	100	
10	1 per ESCC		1

## 6.2.5 Notes on Product Dimension and Terminal Identification

1. Dimensional identification is specified by the component geometry. See Functional Diagram for the terminal connections.
2. Ignored.





- 2. Radio efficiency (range, power, systems).
- 3. Radio efficiency (range, it places).
- 4. Systems.

### 1.4

### FUNCTIONAL SYMBOLS

Terminal 1: Cathode  
Terminal 2: Anode  
Terminal 3: Anode



Terminal 1: Cathode 1  
Terminal 2: Cathode 2  
Terminal 3: Cathode 3



Terminal 1: Anode 1  
Terminal 2: Anode 2  
Terminal 3: Anode 3



Terminal 1: Anode 1  
Terminal 2: Anode 2  
Terminal 3: Anode 3



Terminal 1: Cathode  
Terminal 2: Cathode





**2.2 Mechanical Strength**

The test conditions for Terminal Strength, stated as specified in the ESCC General Specification, shall be as follows:

For TD-88, Test Condition 4, applies, with an applied force of 100N for a duration of 10s.

**2.4 ELECTRICAL CHARACTERISTICS AT ROOM TEMPERATURE (TEMPERATURE)**

Starting measurements shall be performed at room, high and low temperatures. Conditions shown are given after the name.

**2.4.1 Room Temperature Electrical Measurements**

The measurements shall be performed at  $T_{amb} \pm 0.5^{\circ}\text{C}$ .

Characteristic	Symbol	ESCC-020-006 Test Method	Test Conditions (Notes 1)	Limits		Units
				Min.	Max.	
Nominal Current	$I_N$	200A	200 Ampere $V_{max} = 200V$	-	20	µA
Nominal Voltage	$V_N$	200V	200 Volt (Notes 1 & 2)	-	1	V
	$V_{N1}$	200V	200 Volt (Notes 1 & 2)	-	1.2	V
Maximum Voltage	$V_{max}$	200V	1.2 x $V_N$ (Notes 1 & 2)	200	-	V
Impedance	Z	200V	$V_N / I_N$ (Notes 1 & 2)	-	200	µΩ
Reverse Recovery Time	$t_{rr}$	200V	See Condition 4. $V_{max}$ $I_{N1}$ $V_{N1}$ (Notes 1 & 2)	-	20	ns
Storage Temperature, Junction Case	$T_{stg(jct)}$	200V	1.7 x $T_{amb}$ $T_{stg(jct)}$ = 100°C $T_{stg(jct)}$ = 100°C $T_{stg(jct)}$ = 100°C	(Calculation only, see Note 4)		100°C

**2.4.2 High and Low Temperature Electrical Measurements**

Characteristic	Symbol	ESCC-020-006 Test Method	Test Conditions (Notes 1 & 2)	Limits		Units
				Min.	Max.	
Nominal Current	$I_N$	200A	$V_{max} = 200V$ (Notes 1 & 2) 200 Ampere $V_N = 200V$	-	20	µA



Characteristic	Symbol	Type, Unit, and Test Method	Test Conditions (Notes 1 apply)	Limits		Units
				Min <sup>1</sup>	Max <sup>2</sup>	
Forward Voltage I	$V_{f1}$	VDC	Forward Voltage I <sub>DC</sub> at $I_{f1}$ (see Paragraph 2.4.2.1)	-	0.85	V <sup>1</sup>
			Forward Voltage I <sub>DC</sub> at $I_{f1}$ (see Paragraph 2.4.2.1)	-	1.15	V <sup>1</sup>

**2.4.2.1. Test and Electrical Measurement Tolerances**

- Measurements per each diode.
- Probe width within 0.01mm (0.0004 in).
- Perform test only during forwarding. Tests for proper diode values (initial/maximum/avg) as per pg. 10 of instruction.  $I_{f1}$  shall be defined by the manufacturer accuracy list in accordance with MIL-STD-883C, Method 20. If an additional parameter the  $I_{f1}$  limits specified in Maximum Ratings.
- Final and repeat measurements shall be performed on a sample of 5 components with 2 failures allowed. Alternatively a 100% inspection may be performed.

**2.4.3. PERFORMANCE POINT (TEMPERATURE)**

Unless otherwise specified, the measurements shall be performed at  $T_{amb} = 25 \pm 0.5^\circ\text{C}$ .

The test methods and test conditions shall be as per the corresponding test defined in Room Temperature Electrical Measurements.

The test values (a) shall not be exceeded for each characteristic specified. The corresponding minimum test values for each characteristic shall not be exceeded.

Characteristic	Symbol	Limits		Units	
		Min Value (a)	Max Value		
			Min <sup>1</sup>		Max <sup>2</sup>
Reverse Current	$I_{r1}$	50 μA (IF) ± 100%	-	50	μA
Forward Voltage I	$V_{f1}$	0.85	-	0	V

**NOTES:**

- Min/Max is the greater referred to the initial value.

**2.4.4. PERFORMANCE POINT (ELECTRICAL MEASUREMENTS)**

Unless otherwise specified, the measurements shall be performed at  $T_{amb} = 25 \pm 0.5^\circ\text{C}$ .

The test methods and test conditions shall be as per the corresponding test defined in Room Temperature Electrical Measurements.



The instructions for each characteristic shall not be exceeded.

Characteristic	Symbol	Limits		Units
		Min.	Max.	
Minimum Current	$I_{min}$	-	100	$\mu A$
Maximum Voltage	$V_{max}$	-	1	V

## 2.7 POWER SUPPLY VOLTAGE AND CURRENT CONDITIONS

Characteristic	Symbol	Limits	Units
Minimum Temperature	$T_{min}$	-40 to +125	$^{\circ}C$
Minimum Voltage	$V_{min}$	100	V
Current	I	1.00	mA

## 2.8 POWER SUPPLY CONDITIONS

Characteristic	Symbol	Test Conditions	Units
Power Temperature	$T_{max}$	100% at 100 100% at 1	$^{\circ}C$
Minimum Temperature	$T_{min}$	-40 to +125	$^{\circ}C$
Average Output Current Constant	$I_{avg}$	100% at 1, 2	A

### Notes:

1. Minimum temperature and/or output current may be adjusted, within the specified ranges, to obtain the specified junction temperature.
2. Both notes shall be read together for common anode and common cathode devices.  
 $I_{avg}$  is 10 mA for each leg of devices (a), (b) and (c).  
 $I_{avg}$  is 10 mA for variants (d), (e) and (f).

## 2.9 ESCC Test and Conditions

The conditions shall be as specified in Power Supply.



## APPENDIX

### TABLE OF CONTENTS FOR SEEDS OF CEREALS

ITEM NUMBER	DESCRIPTION OF DOCUMENT
Appendix 1 Production Control Chart 10	ESCC Production Control - Production Seed Support. Budgets and expenses. Critical dimensions are compatible for handling with a 100 mm roll.
Appendix 11 Sowing Time Chart 10	Seedling's development under optimum. Agreement with National Data.